

AOD4286/AOI4286

100V N-Channel MOSFET

General Description

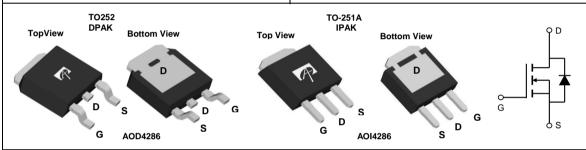
The AOD4286, AOI4286 uses trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{\text{DS(ON)}},$ Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Product Summary

 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 14A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 68m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 92m\Omega \end{array}$

100% UIS Tested





Absolute Maximum Ratings T _A =25°C unless oth	se noted
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Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain	T _C =25°C	1	14		
Current	T _C =100°C	I _D	10	А	
Pulsed Drain Curren	t ^C	I _{DM}	25		
Continuous Drain Current	T _A =25°C		4	А	
	T _A =70°C	IDSM	3	A	
Avalanche Current ^C		I _{AS}	4	А	
Avalanche energy L:	=0.1mH ^C	E _{AS}	0.8	mJ	
	T _C =25°C	В	30	W	
Power Dissipation ^B	T _C =100°C	$-P_{D}$	15	VV	
	T _A =25°C	В	2.5	10/	
Power Dissipation ^A	T _A =70°C	P _{DSM}	1.6	W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	15	20	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	П	41	50	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	4	5	°C/W	



Electrical Characteristics (T_{.1}=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units	
STATIC I	PARAMETERS							
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		100			V	
ı	Zoro Coto Voltago Droin Current	V _{DS} =100V, V _{GS} =0V				1		
I _{DSS}	Zero Gate Voltage Drain Current		T _J =55°C			5	μА	
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm20V$				±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.7	2.25	2.9	V	
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V		25			Α	
		V_{GS} =10V, I_{D} =5A			55.5	68	m()	
R _{DS(ON)}	Static Drain-Source On-Resistance	ance T _J =125°C			104	126	mΩ	
		V_{GS} =4.5V, I_D =3A			72.5	92	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =5A			14		S	
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.76	1	V	
Is	Maximum Body-Diode Continuous Cur	rrent			14	Α		
DYNAMI	C PARAMETERS		•		-		-	
C _{iss}	Input Capacitance				390		pF	
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =50V, f=1MHz f=1MHz			30		pF	
C_{rss}	Reverse Transfer Capacitance				3		pF	
R_g	Gate resistance				7		Ω	
SWITCH	ING PARAMETERS	•	•			•		
Q _g (10V)	Total Gate Charge				5.8	10	nC	
Q _g (4.5V)	Total Gate Charge	1, 40,4,4, 50,4,1,54			2.8	5	nC	
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =50V, I	V_{GS} =10V, V_{DS} =50V, I_{D} =5A		1.1		nC	
Q_{gd}	Gate Drain Charge	1			1.2		nC	
t _{D(on)}	Turn-On DelayTime				6		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =10 Ω , R_{GEN} =3 Ω			2.5		ns	
t _{D(off)}	Turn-Off DelayTime				18		ns	
t _f	Turn-Off Fall Time				2.5		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =5A, dI/dt=500A/μs			15		ns	
Q_{rr}	Body Diode Reverse Recovery Charge	_θ I _F =5A, dI/dt=500A/μs			53		nC	

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=175^{\circ}$ C. Ratings are based on low frequency and duty cycles to keep initial $T_{J}=25^{\circ}$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

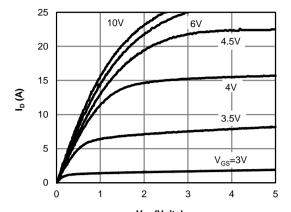
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

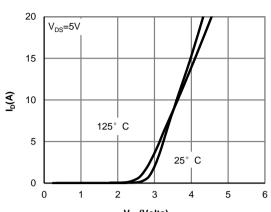
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



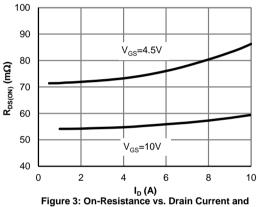
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



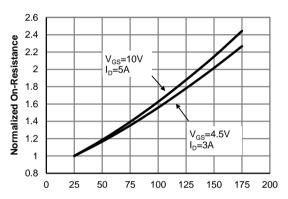
V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



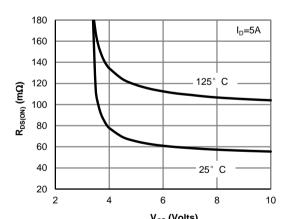
V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



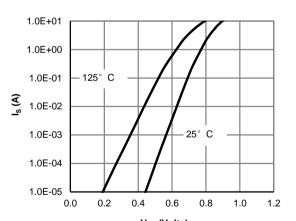
Gate Voltage (Note E)



Temperature (°C) Figure 4: On-Resistance vs. Junction Temperature (Note E)



V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



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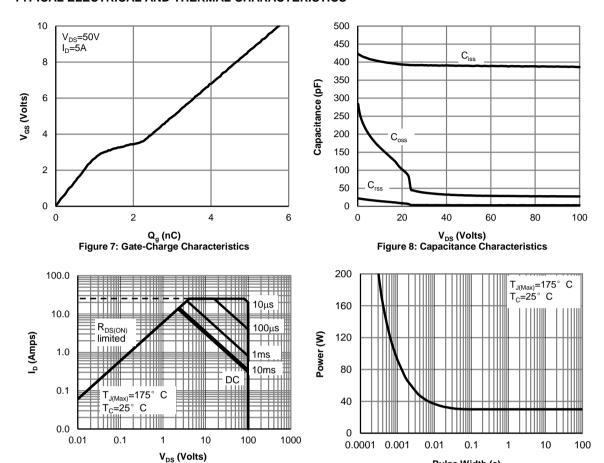
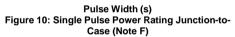


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



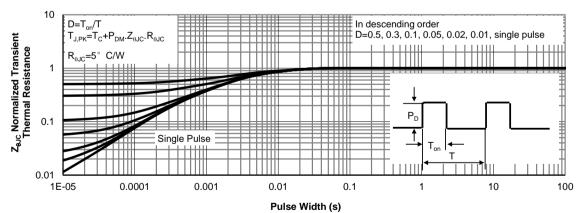
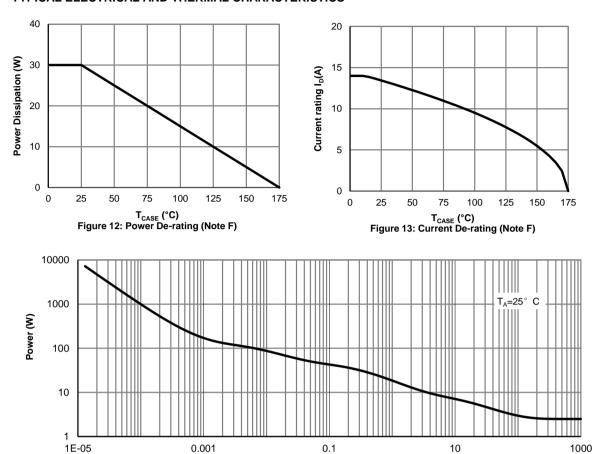


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

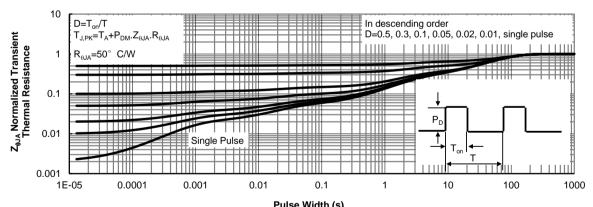
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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

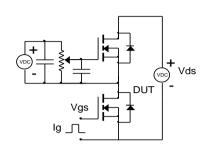


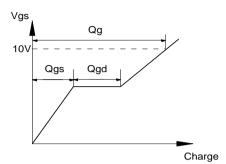
Pulse Width (s)
Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

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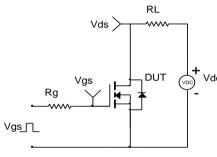


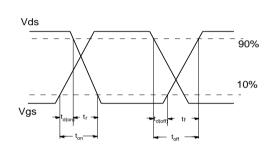
Gate Charge Test Circuit & Waveform



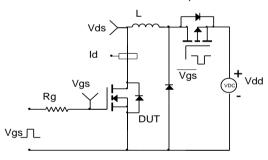


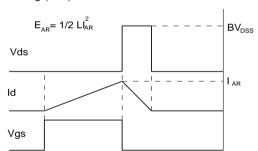
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

